# UNISONIC TECHNOLOGIES CO., LTD

24N65-CB Power MOSFET

## 24A, 650V N-CHANNEL POWER MOSFET

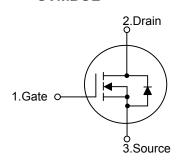
#### DESCRIPTION

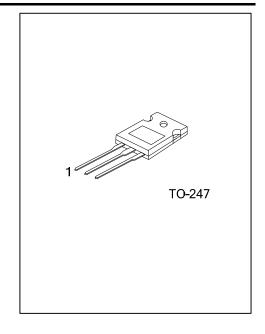
The UTC **24N65-CB** is a high voltage power MOSFET and is designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and have a high rugged avalanche characteristics. This power MOSFET is usually used at high speed switching applications in power supplies, PWM motor controls, high efficient DC to DC converters and bridge circuits.

#### ■ FEATURES

- \*  $R_{DS(ON)}$  < 0.37 $\Omega$  @  $V_{GS}$ =10V,  $I_{D}$ =12A
- \* High Switching Speed
- \* 100% Avalanche Tested

## ■ SYMBOL

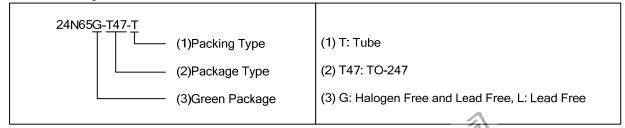




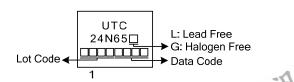
#### ■ ORDERING INFORMATION

Ordering Number		Doolsono	Pin Assignment			Deelsing	
Lead Free	Halogen Free	Package	1	2	3	Packing	
24N65L-T47-T	24N65G-T47-T	TO-247	G	D	S	Tube	

Note: Pin Assignment: G: Gate D: Drain S: Source



## ■ MARKING



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## ■ ABSOLUTE MAXIMUM RATINGS (T<sub>C</sub>=25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		$V_{DSS}$	650	V
Gate-Source Voltage		$V_{GSS}$	±30	V
Drain Current	Continuous	Ι <sub>D</sub>	24	Α
	Pulsed (Note 2)	$I_{DM}$	96	Α
Avalanche Energy	Single Pulsed (Note 3)	$E_AS$	140	mJ
Peak Diode Recovery dv/dt		dv/dt	0.57	V/ns
Power Dissipation		$P_D$	367	W
Junction Temperature		$T_J$	+150	°C
Storage Temperature		$T_{STG}$	-55 ~ +150	°C

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 3. L =10mH,  $I_{AS}$  =5.3A,  $V_{DD}$  = 50V,  $R_{G}$  = 25 $\Omega$ , Starting  $T_{J}$  = 25 $^{\circ}$ C
- 4.  $I_{SD} \le 24A$ , di/dt  $\le 200A/\mu s$ ,  $V_{DD} \le BV_{DSS}$ , Starting  $T_J = 25^{\circ}C$

## **■ THERMAL DATA**

PARAMETER	SYMBOL	RATINGS	UNIT	
Junction to Ambient	$\theta_{JA}$	40	°C/W	
Junction to Case	$\theta_{JC}$	0.34	°C/W	

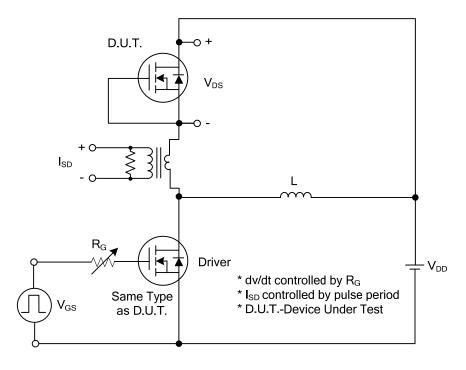
## ■ **ELECTRICAL CHARACTERISTICS** (T<sub>C</sub>=25°C, unless otherwise specified)

PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage		$BV_{DSS}$	$I_D=250\mu A, V_{GS}=0V$	650			V
Drain-Source Leakage Current		I <sub>DSS</sub>	V <sub>DS</sub> =650V, V <sub>GS</sub> =0V			1	μA
Gate- Source Leakage Current	Forward	- Icss	$V_{GS}$ =+30V, $V_{DS}$ =0V			+100	nA
	Reverse		$V_{GS}$ =-30V, $V_{DS}$ =0V			-100	nA
ON CHARACTERISTICS							
Gate Threshold Voltage		$V_{GS(TH)}$	$V_{DS}=V_{GS}$ , $I_D=250\mu A$	2.0		4.0	V
Static Drain-Source On-State Resistance		R <sub>DS(ON)</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =12A			0.37	Ω
DYNAMIC PARAMETERS							
Input Capacitance		$C_{ISS}$			4100		pF
Output Capacitance		Coss	$V_{GS}$ =0V, $V_{DS}$ =25V, f=1MHz		350		pF
Reverse Transfer Capacitance		$C_{RSS}$			6		pF
SWITCHING PARAMETERS							
Total Gate Charge		$Q_G$	V <sub>DS</sub> =400V, V <sub>GS</sub> =10V, I <sub>D</sub> =20A		75		nC
Gate to Source Charge		$Q_GS$	$I_{G}$ = 1mA (Note1, 2)		29		nC
Gate to Drain Charge		$Q_GD$	IG- IIIA (Note I, 2)		15		nC
Turn-ON Delay Time		$t_{D(ON)}$			50		ns
Rise Time		$t_R$	V <sub>DS</sub> =300V, V <sub>GS</sub> =10V, I <sub>D</sub> =20A,		25		ns
Turn-OFF Delay Time		t <sub>D(OFF)</sub>	R <sub>G</sub> =25Ω (Note1, 2)		192		ns
Fall-Time		$t_{F}$			46		ns
SOURCE- DRAIN DIODE RATII	NGS AND	CHARACTERI	STICS				
Maximum Body-Diode Continuou	us Current	I <sub>S</sub>	2 112	0		24	Α
Maximum Body-Diode Pulsed Current		I <sub>SM</sub>	The Co	),,		96	Α
Drain-Source Diode Forward Voltage		$V_{SD}$	I <sub>S</sub> =24A, V <sub>GS</sub> =0V			1.4	V
Body Diode Reverse Recovery Time		t <sub>rr</sub>	$I_S=24A$ , $V_{GS}=0V$ ,		420		ns
Body Diode Reverse Recovery Charge		Q <sub>rr</sub>	dl₅/dt=100A/µs (Note 1)		5.8		μC

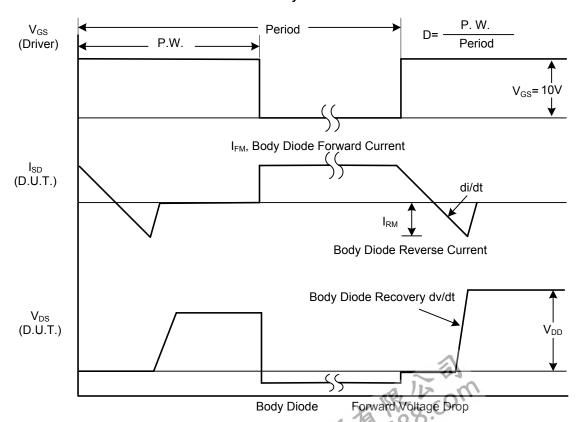
Notes: 1. Pulse Test : Pulse width  $\leq$  300 $\mu$ s, Duty cycle  $\leq$  2%.

2. Essentially independent of operating ambient temperature.

## **■ TEST CIRCUITS AND WAVEFORMS**



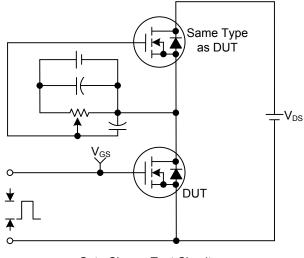
## Peak Diode Recovery dv/dt Test Circuit

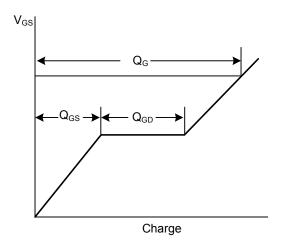


Peak Diode Recovery dwdt Waveforms

24N65-CB **Power MOSFET** 

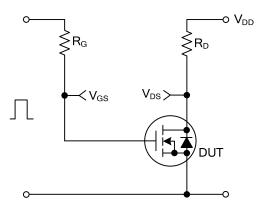
## **TEST CIRCUITS AND WAVEFORMS**



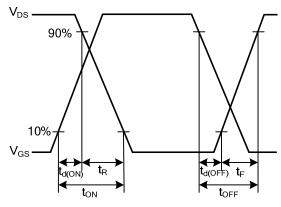


Gate Charge Test Circuit

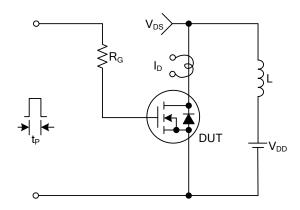
Gate Charge Waveforms



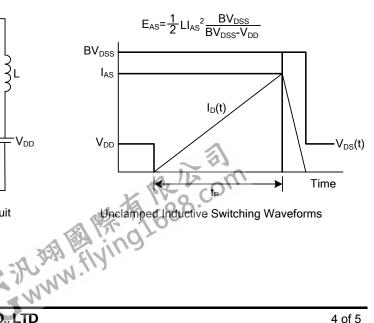




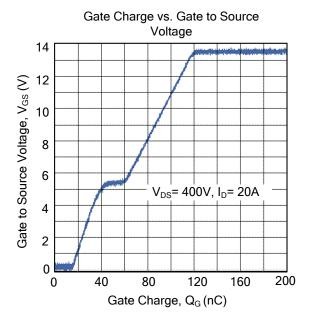
Resistive Switching Waveforms

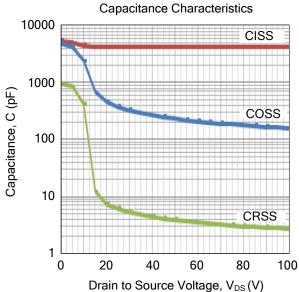


Unclamped Inductive Switching Test Circuit



## ■ TYPICAL CHARACTERISTICS





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